Component Title:

Diodes, Microwave, Silicon, Hyper-abrupt junction Tuning Varactor, based on types DH 76XXX

Executive Member:

CNES

Date: 30/06/2015

Appl. No. 273E

ESCC COMPONENT VARIANTS NO.			DAMES	BASED		TEST	СОМРО	NENT	
		5	RANGE OF CO	ON	78	VEHICLE / S	SIMIL		
5512/023-01-72 01 to 72			Cj(-4V) = 1.0 pF to	DH 76010 to 150		5512/023-64	All others var	All others variants	
Component Manufacturer 2 Cobham Microwave			Location of Manufacturing Plant(s) 31, avenue de la Baltique 91978 VILLEBON-SUR-YVETTE Cdex France			Date of original qualification approval: Date: 01/06/2003 Certificate Ref No. 273			
ESCC Specification	s used for	5	Deviations to LVT to	esting and Detail	6 Specification	Quali	fication Extension Rep	ort	7
Maintenance of qua	lification testing:		used:		3 1000 0	reference and date:			
Generic: 5010 Issue: 1 Detail(s): 5512/023 Issue: 2			No ⊠ Yes ☐ (supply details in Box 15) Deviation from current Specifications: No ⊠ Yes ☐ (Supply details)			2015	062976-223 dated 24.0	06.2015	
Summary of procure	ement or equivalen	it test re	esults during current v	alidity period in s	upport of this ap	plicatio	n (those to ESCC lister	d first)	8
Summary of procure Project Name	ement or equivalen	20 707	esults during current v	alidity period in s	upport of this ap	plicatio	n (those to ESCC listed	d first) tity Delivered	8
STATE OF STATES	3-342 70324	20 707		alidity period in s	CS13 - U/A - U/O		(7.2.1		8
Project Name	3-342 70324	20 707	LAT		CS13 - U/A - U/O		Quant		8
Project Name Various	3-342 70324	20 707	LAT 2	1324	CS13 - U/A - U/O		Quant 534		8
Project Name Various Various Various	Testing L	_evel	LAT 2 LAT 2	1324 1351 Various	Date code		Quant 534 460 1318		
Project Name Various Various Various PID changes since	Testing L	_evel	LAT 2	1324	Date code		Quant 534 460 1318 J.L. Roux	ity Delivered	
Project Name Various Various Various	Testing L	_evel	LAT 2 LAT 2	1324 1351 Various Current PID Ref No:	Date code		Quant 534 460 1318	sentative	10
Project Name Various Various PID changes since s None Minor* Minor*	Testing I	_evel	LAT 2 LAT 2	1324 1351 Various Current PID Ref No: Issue:	Date code Verified by: PID 304		Quant 534 460 1318 J.L. Roux ame of Excutive Repres	sentative	10
Project Name Various Various PID changes since s None Minor* Minor*	Testing I	evel	LAT 2 LAT 2	1324 1351 Various Current PID Ref No: Issue:	Verified by: PID 304 Rev. F 30/06/2015		Quant 534 460 1318 J.L. Roux ame of Excutive Repre	sentative	10
Project Name Various Various Various PID changes since : None	Testing I	evel	LAT 2 LAT 2 - 9	1324 1351 Various Current PID Ref No: Issue: Rev Date:	Verified by: PID 304 Rev. F 30/06/2015	N	Quant 534 460 1318 J.L. Roux ame of Excutive Repre	sentative	10
Project Name Various Various Various PID changes since : None	Testing I	evel	LAT 2 LAT 2 LAT 2 - (Name	1324 1351 Various Current PID Ref No: Issue: Rev Date: ESA and CN	Verified by: PID 304 Rev. F 30/06/2015	N	Quant 534 460 1318 J.L. Roux ame of Excutive Repre	sentative le: 30/06/20	10

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL Page 2 Diodes, Microwave, Silicon, Hyper-abrupt junction Tuning Varactor, based on types DH 76XXX Component title: Appl. No. **Executive Member** CNES Date: 30/06/2015 273E 12 Failure Analysis, DPA, NCCS available: X (Supply data) Yes No Ref. No's and purposes: 13 The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence (except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of CNES as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein. Date: 17/07/2015 P.I. Philippe LAY (Head of Components and Qualification Section) for JP.BUSSENOT (Signature of the Executive Coordinator) Continuation of Boxes above: 14 Box 9: Editorial changes (organigram update, plan updated, docs index update) Box 11 : Audit report QCS/LB/08101 (28/01/2008) and Audit Close-out Report QCS/LB/090302 (31/03/2009). Additional survey conducted on 08.03.2010 in the frame of a NRB on DH76xxx diodes.

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		Executive Member	CNES	Date: 30/06/2015	273E
Non compliance	to ESCC requirements	s:			15
No.:	Specification		Paragraph	Non comp	liance
		-			
Additional tasks	required to achieve full	compliance for ESCC q	ualification or rationale for accep	otability of	16
noncompliance:					19
	5:				
Executive Mana					17
Application Appr Action / Remark		No 🗆			
Action / Remark	S .				
				6 1	
					01
Date:				- 00	
				Signature, ESA Represen	tative

Component Title:

Diodes, Microwave, Silicon, Hyper-abrupt junction Tuning Varactor, based on types DH 76XXX

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ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

Tests conducted in compliance with:

ESCC 5010 generic specification; Chart V (for ESCC/QPL parts); Or PID-TFD (for ESCC/QML parts)

Tests vehicle identification/description:

DH 76150 in package M208a	

Detail Specification reference:

ESCC No 5512 / 023 Issue 2

Chart V	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
Environmental/Mechanical Subgroups	Thermal Shock Test	×	ESCC 5010 Para. 9.5.2	1446	6	0	
	Shock Test		MIL-STD-750 Test Method 2016				
	Vibration Test		MIL-STD-750 Test Method 2056				
	Constant Acceleration		MIL-STD-750 Test Method 2006				
	Seal Test	×	MIL-STD-750 Test Method 1071	1446	6	0	
	Moisture Resistance	×	MIL-STD-750 Test Method 1021	1446	6	0	
	Seal Test	×	MIL-STD-750 Test Method 1071	1446	6	0	
	Electrical Measurements at Room Temp.	Ø	Table 2 of the Detail Specification	1446	6	0	
	External Visual Inspection		ESCC Basic Specification No. 20500	1446	6	0	
Endurance Subgroup	Operating Life	×	MIL-STD-750 Test Method 1026	1446	8	0	
	Electrical Measurements during Endur. Test	×	Table 6 of the Detail Specification	1446	8	0	
	External Visual Inspection	×	ESCC Basic Specification No. 20500	1446	8	0	



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Chart V	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
Electrical Subgroup – Electrical Measurements	Electrical Measurements at Room Temp.	×	Table 2 of the Detail Specification	1446	4	0	
	Electrical Measurements at High & Low Temp's	×	Table 3 of the Detail Specification	1446	4	0	
	External Visual Inspection	×	ESCC Basic Specification No. 20500	1446	4	0	
	Special Testing		The Detail Specification				
Electrical Subgroup - Assembly Capability Tests	Solderability Test	×	MIL-STD-750 Test Method 2026	1446	2	0	
	Permanence of Marking	×	ESCC Basic Specification No. 24800	1446	2	0	
	Terminal Strength	\boxtimes	MIL-STD-750 Test Method 2036	1446	2	0	
lal							
Additional Tests							
PG							



Diodes, Microwave, Silicon, Hyper-abrupt junction Tuning Varactor, based on types DH $76\mathrm{XXX}$ Component title:

Date: 30/06/2015 CNES Executive Member:

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	NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL
ENTRIES Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.
Box 21	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 22	Additional Comments.